### 2014 Rapid DNA Maturity Assessment Results

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CODIS State Administrator Meeting May 12, 2015 Norman, OK







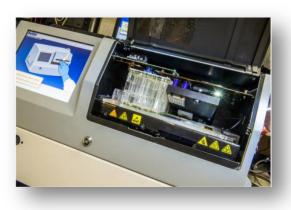
### Disclaimer

- Points of view in this document are those of the authors and do not necessarily represent the official position or policies of the U.S. Department of Commerce. <u>Certain commercial</u> <u>equipment, instruments, and materials are identified in order</u> to specify experimental procedures as completely as possible.
- In no case does such identification imply a recommendation or endorsement by NIST, nor does it imply that any of the materials, instruments, or equipment identified are necessarily the best available for the purpose.

### Purpose of Maturity Assessment

- To assess the current status of rapid DNA typing technology for the CODIS core loci
  - In support of lab and future external (non-labbased) Rapid DNA implementation
- Integrated (swab in allele detection) instruments capable of genotyping the core CODIS 13 STR markers were eligible for the study

#### **Rapid DNA Instruments ANDE (NetBio) RapidHIT 200 (IntegenX)**



- One biochipset
  - Stored at RT
  - Shelf life  $\approx 6$  months

PowerPlex 16 loci ≈86 min runtime (5 samples)

ANDE PP16



- Kit = 4 components
  - Stored between RT-4°C
  - Shelf life  $\approx$  5 months @ 4°C •

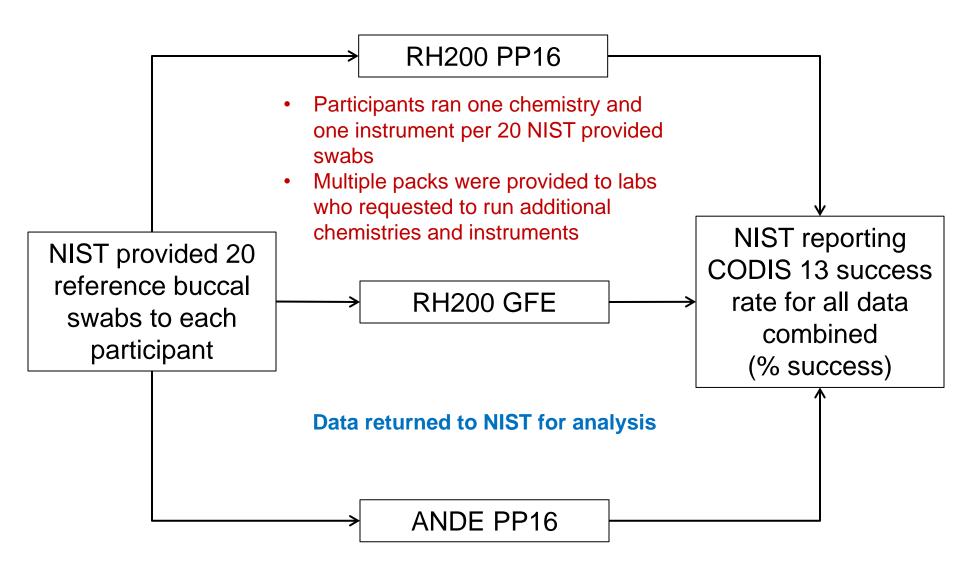
PowerPlex 16 loci ≈90 min runtime (5 samples)

GlobalFiler Express loci ≈120 min runtime (1-7 samples)

#### **RH200 PP16**

**RH200 GFE** 

#### **R-DNA Maturity Assessment**



#### **Timeline of Maturity Assessment**

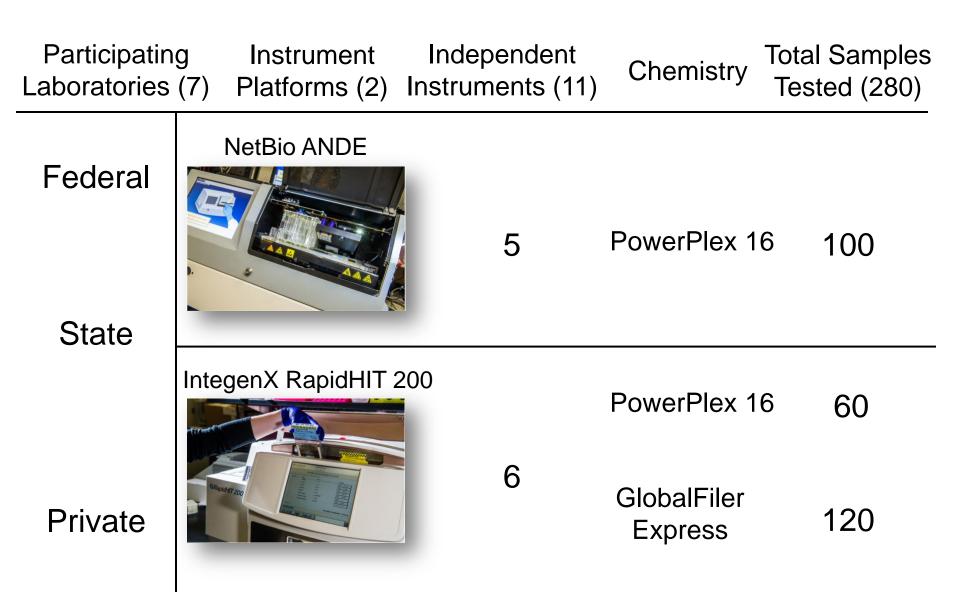
January 2014: Buccal samples collected at NIST and stored at RT

**October 2014:** Samples shipped to participating laboratories

**October-December 2014:** Data electronically returned to NIST

November 2014 – May 2015: Data analyzed at NIST 20 Swabs provided

#### Maturity Assessment



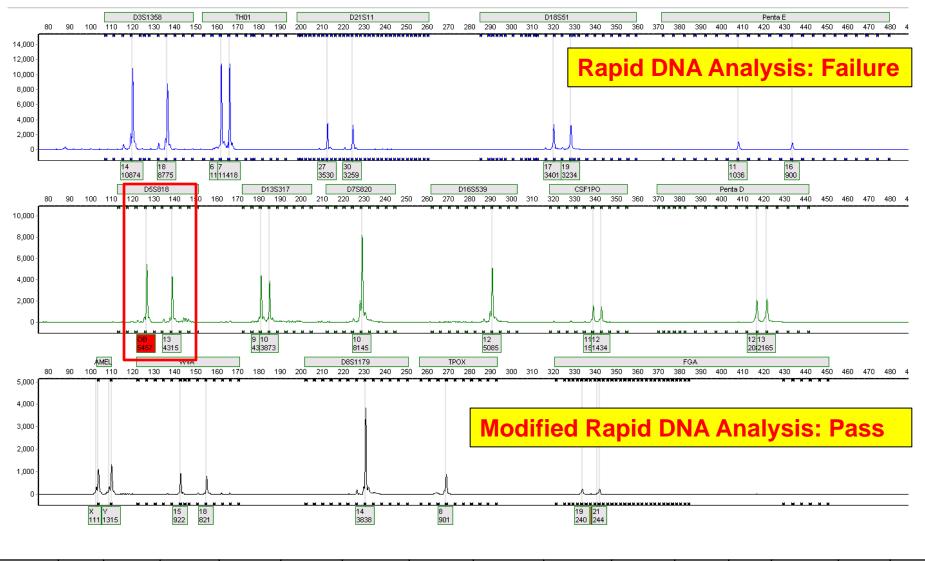
### **NIST** Analysis Parameters

- Rapid DNA Analysis: Without human intervention
- Modified Rapid DNA Analysis: Expert
   interpretation and analysis of electropherogram

http://swgdam.org/docs.html

 Additional analysis (PHR, Stutter, etc.) of the data performed with GeneMapper IDX v 1.3

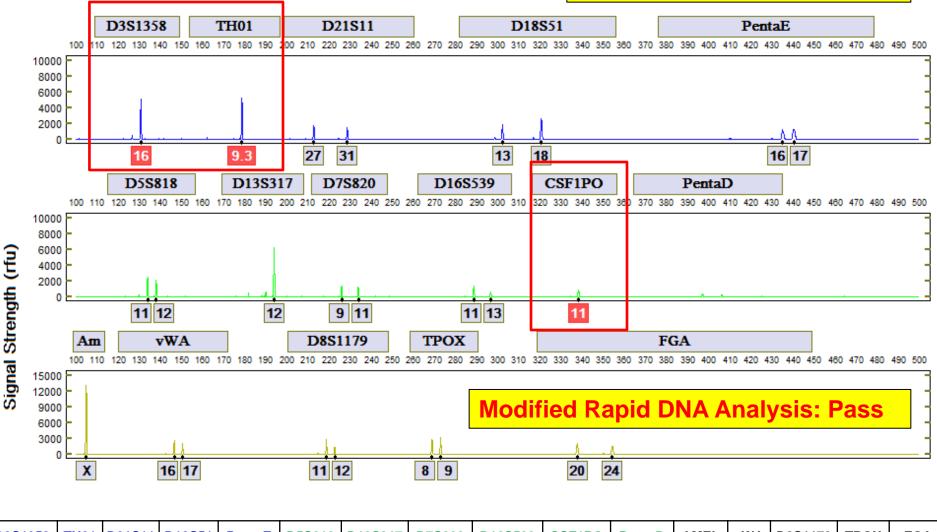
D3S1358	<b>TH01</b>	D21S11	D18S51	PentaE	D5S818	D13S317	D7S820	D16S539	CSF1PO	PentaD	AMEL	vWA	D8S1179	трох	FGA



D3S1358	<b>TH01</b>	D21S11	D18S51	PentaE	D5S818	D13S317	D7S820	D16S539	CSF1PO	PentaD	AMEL	vWA	D8S1179	трох	FGA

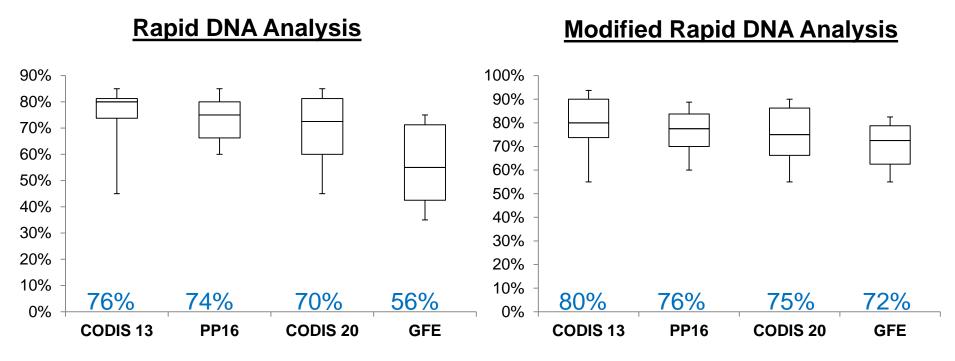
D3S1358	TH01	D21S11	D18S51	PentaE	D5S818	D13S317	D7S820	D16S539	CSF1PO	PentaD	AMEL	vWA	D8S1179	трох	FGA

#### Rapid DNA Analysis: Failure



D3S1358	TH01	D21S11	D18S51	PentaE	D5S818	D13S317	D7S820	D16S539	CSF1PO	PentaD	AMEL	vWA	D8S1179	ΤΡΟΧ	FGA

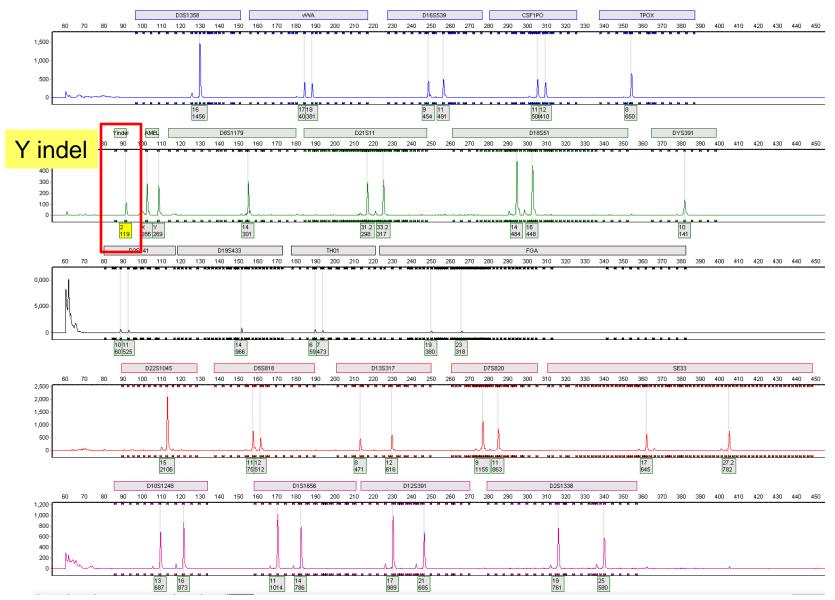
#### **Overall Success**



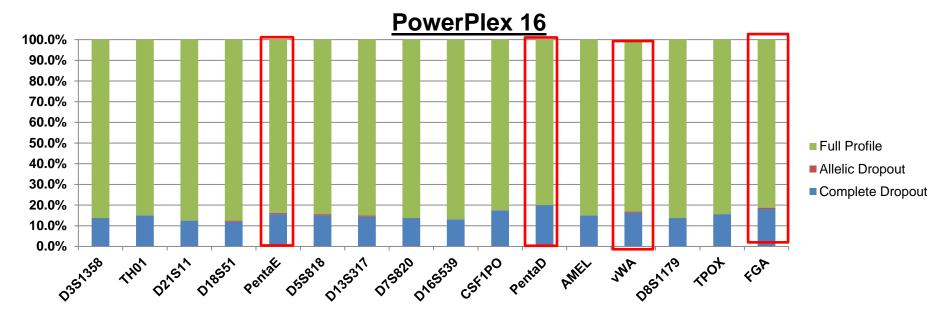
8 samples were passed (for CODIS 13) by performing modified rapid DNA analysis across all platforms (76  $\rightarrow$  80%)

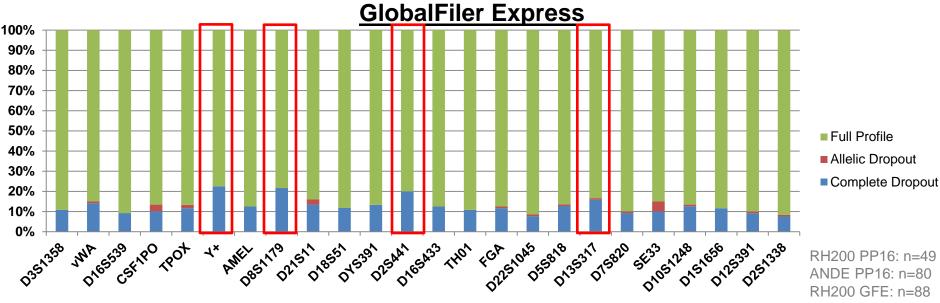
- 2 Samples within the RH200 PP16
- 3 Samples within the RH200 GFE
- 3 Samples within the ANDE PP16

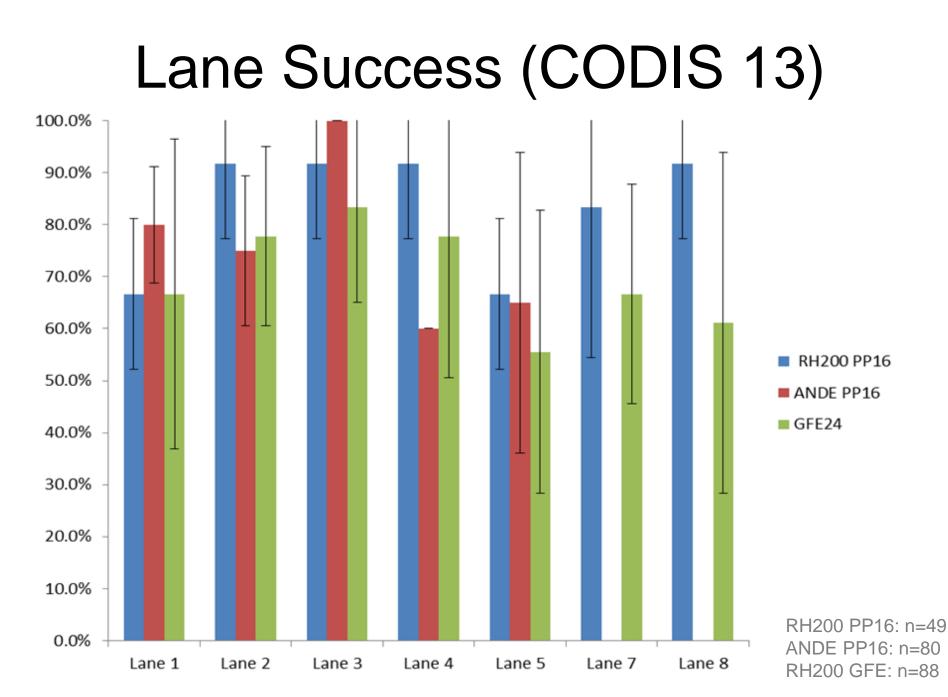
## Higher success with manual review of GFE



#### Locus Success (Rapid Analysis)



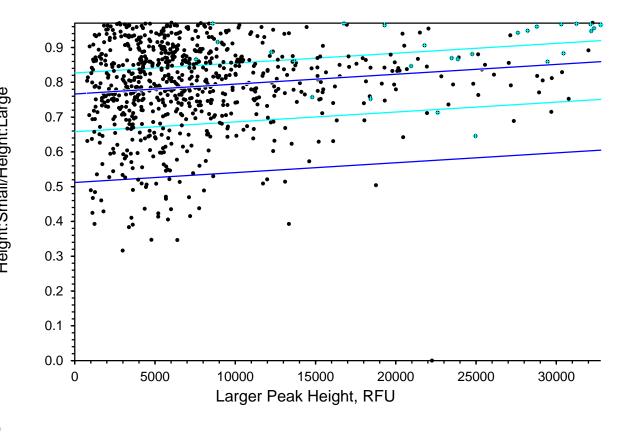




#### **Peak Height Ratios**

#### Median PHR for CODIS 13 loci

			_
Locus	#Ratio	Median	_
D8S1179	55	0.813	
D21S11	43	0.825	ה
D18S51	62	0.827	÷
FGA	67	0.829	
TPOX	44	0.832	Ŧ
D16S539	52	0.835	Heidht:Small/Heidht·Larde
vWA	65	0.844	Ū.
D7S820	47	0.850	ht:
D3S1358	61	0.855	
D5S818	36	0.863	I
CSF1PO	61	0.870	
D13S317	44	0.871	
TH01	28	0.939	

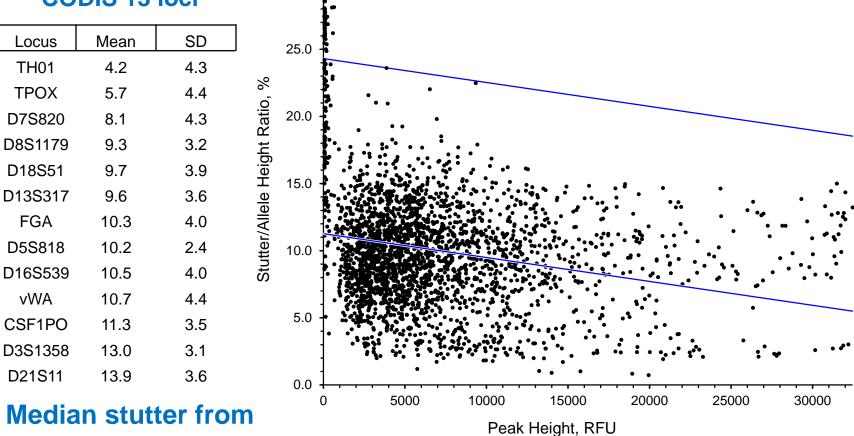


Median peak height ratio greater than 75% for all loci

#### **Stutter Percentage**

#### Mean stutter for CODIS 13 loci

4.2% to 13.9%



Full Profiles: n=252

 $Y = \{11.264 \pm 0.131\} + \{-1.78E-04 \pm 1.4E-05\}X$ 

#### Thresholds

As described by vendors and currently understood at NIST

- IntegenX employs dynamic thresholding
  - Each run has an independent analytical and stochastic threshold calculated via a programed algorithm
  - Locus specific dynamic thresholds set within software
- NetBio employs a static threshold applied to all data uniformly

### IntegenX Thresholds

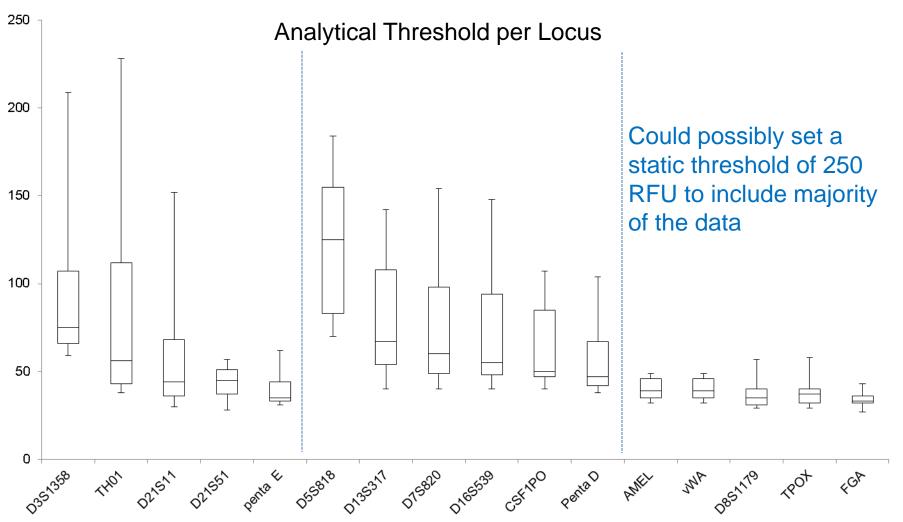
#### Analysis Parameters

Locus	Stochastic	Analytical
	Threshold	Threshold
D3S1358	112	56
vWA	49	25
D16S539	37	18
CSF1PO	36	18
TPOX	33	17
Yindel	221	111
AMEL	49	25
D8S1179	100	50
D21S11	75	37
D18S51	66	33
DYS391	77	38
D2S441	419	209
D19S433	224	112
TH01	111	55
FGA	77	39
D22S1045	198	99
D5S818	142	71
D13S317	133	66
D7S820	145	72
SE33	164	82
D10S1248	701	350
D1S1656	422	211
D12S391	270	135
D2S1338	169	84

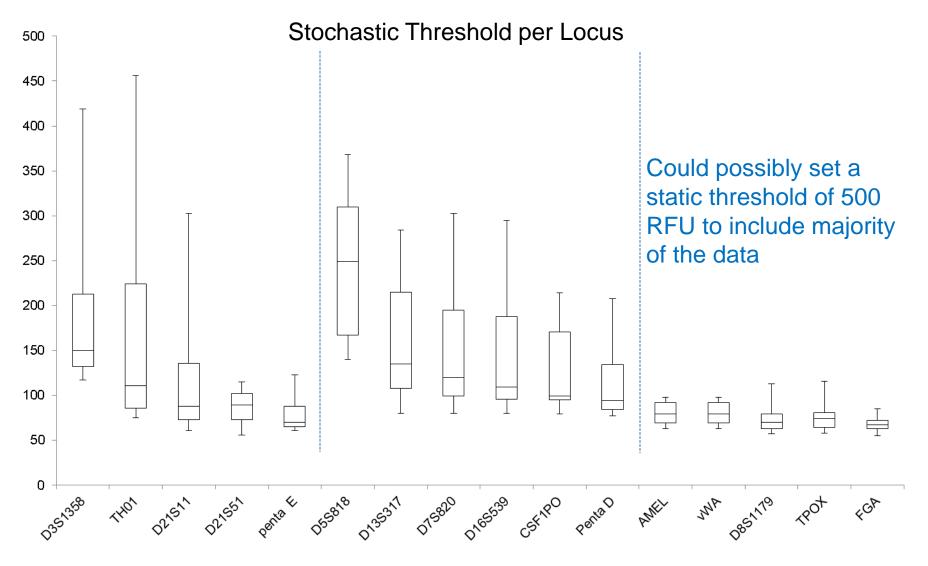
- Can be located in the report file generated per sample
- Table format with PDF report

 Data has been transcribed into an Excel file for analysis

### IntegenX PP16 Thresholds

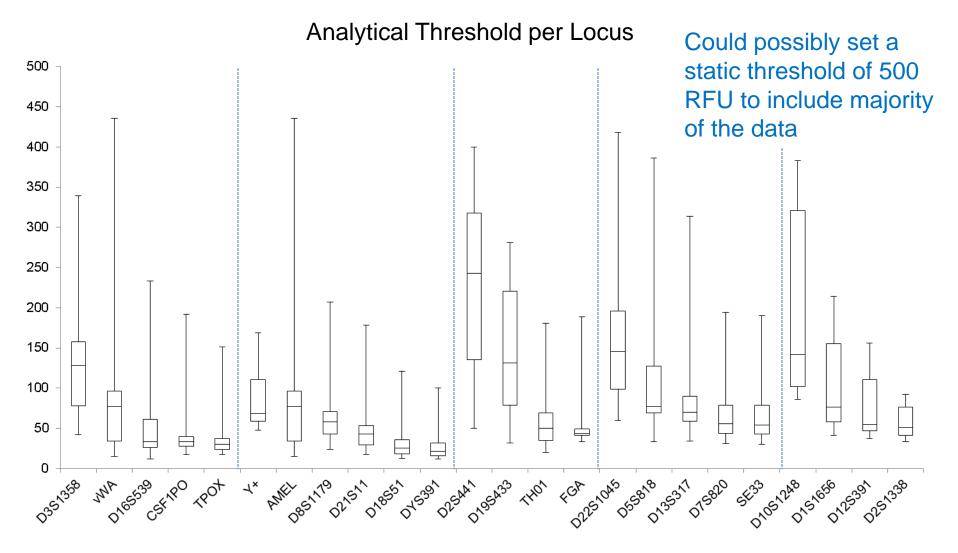


### IntegenX PP16 Thresholds



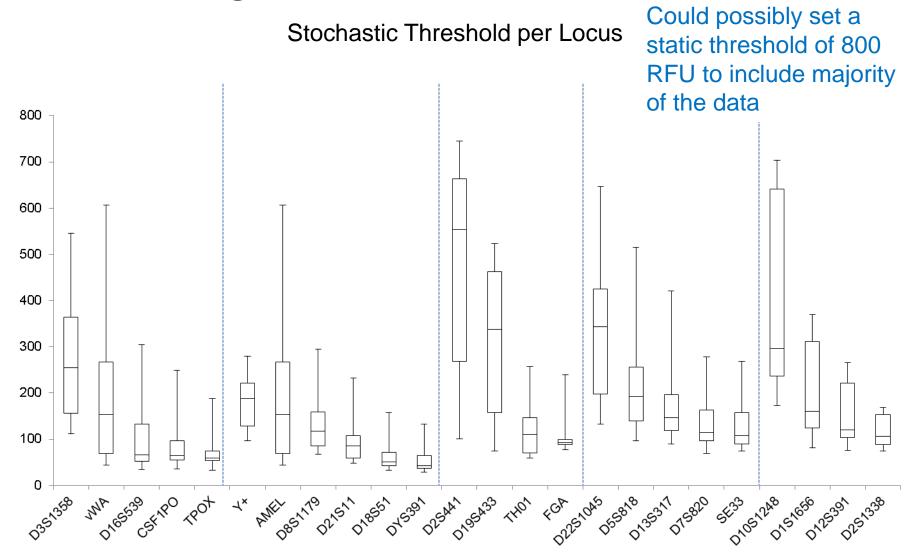
Thanks to Sanae Lembirik

### IntegenX GFE Thresholds



Thanks to Sanae Lembirik

### IntegenX GFE Thresholds

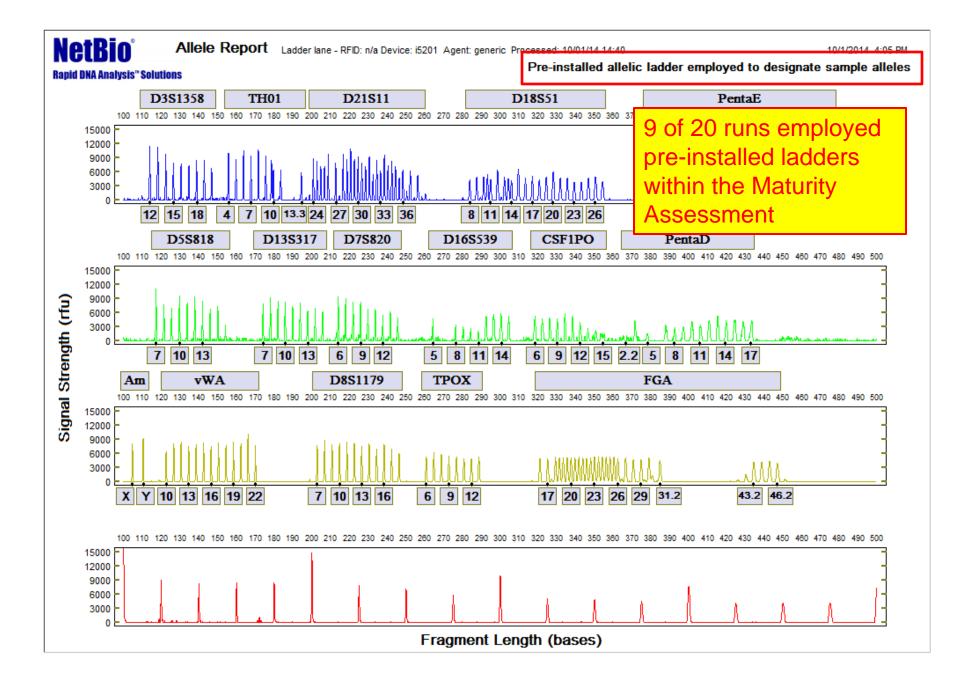


#### Ladders

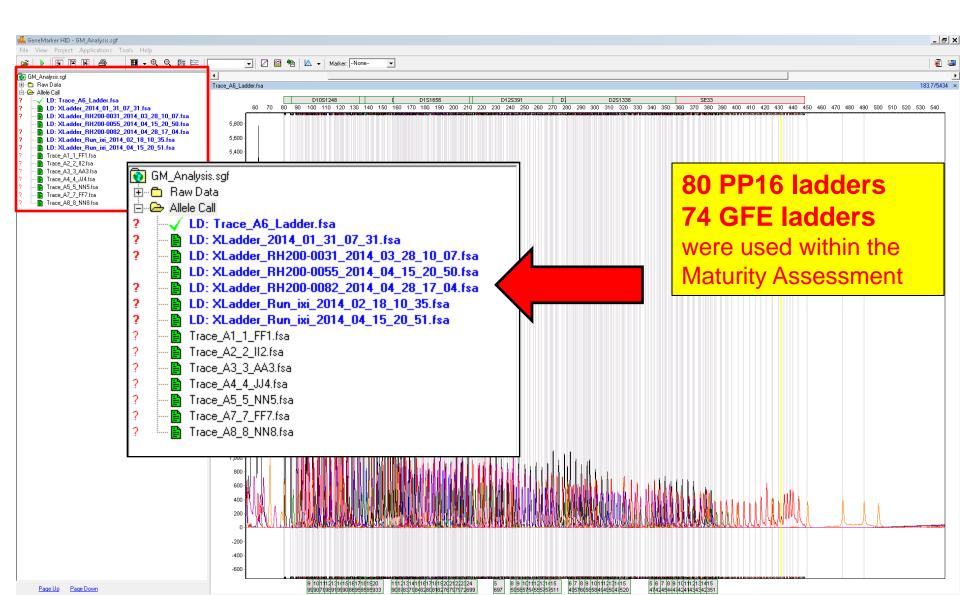
As described by vendors and understood by NIST

- Both instruments contain "onboard" ladders

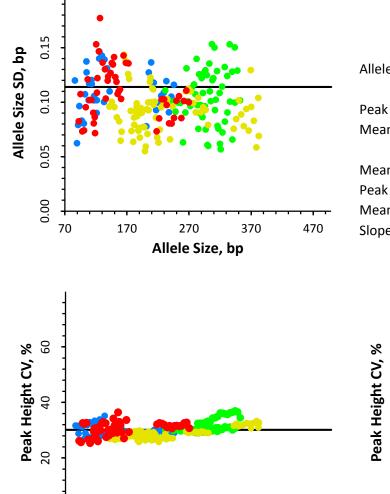
   For use if the ladder on the chip fails
- IntegenX
  - "Fit best Ladder" Algorithm
  - Database of ~200 ladders uploaded into each instrument used to find best ladder per sample
    - Uses size standard and algorithm fitting per sample
- ANDE
  - Onboard ladder file saved and applied to data when chip ladder fails



#### IntegenX Ladders



#### IntegenX Ladder Precision



0

70

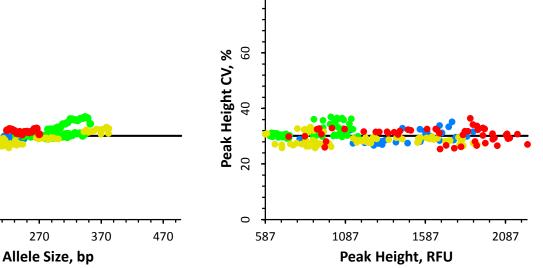
170

#### **RapidHIT 200: GlobalFiler Express**

Allele size SD: 0.114 bp

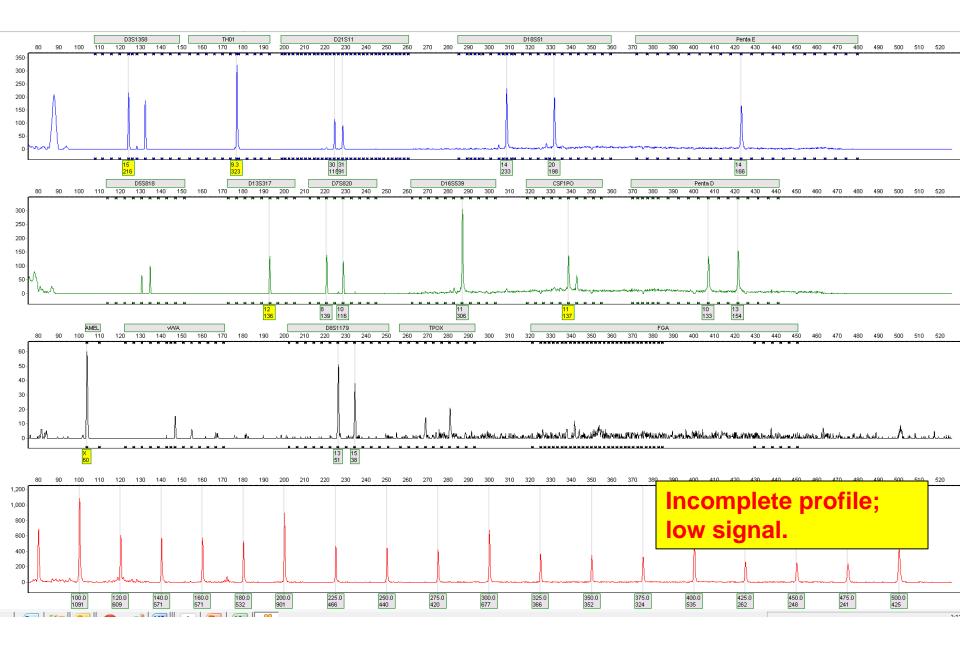
Peak Height CV: 30.1 % Mean Peak Height: 1251 RFU

Mean Peak Area: 6909 RFU × bp Peak Area CV: 30.1 % Mean Peak Width: 5.4 bp Slope {CV(Area),CV(Height)}: 0.998



# Examination of the remaining ~20% samples that were not successful

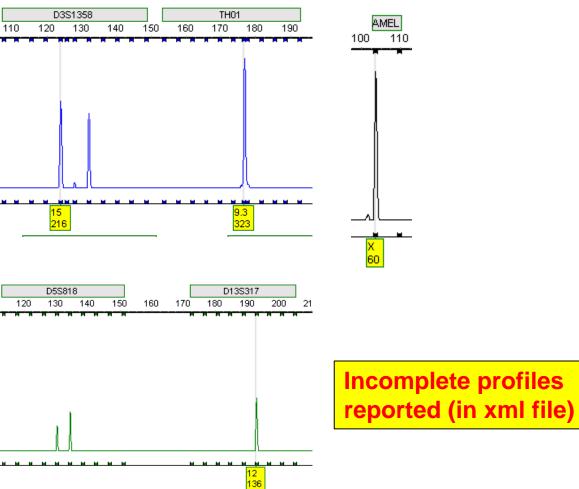
Examples observed between at least 2 individual datasets within the Maturity Assessment Data

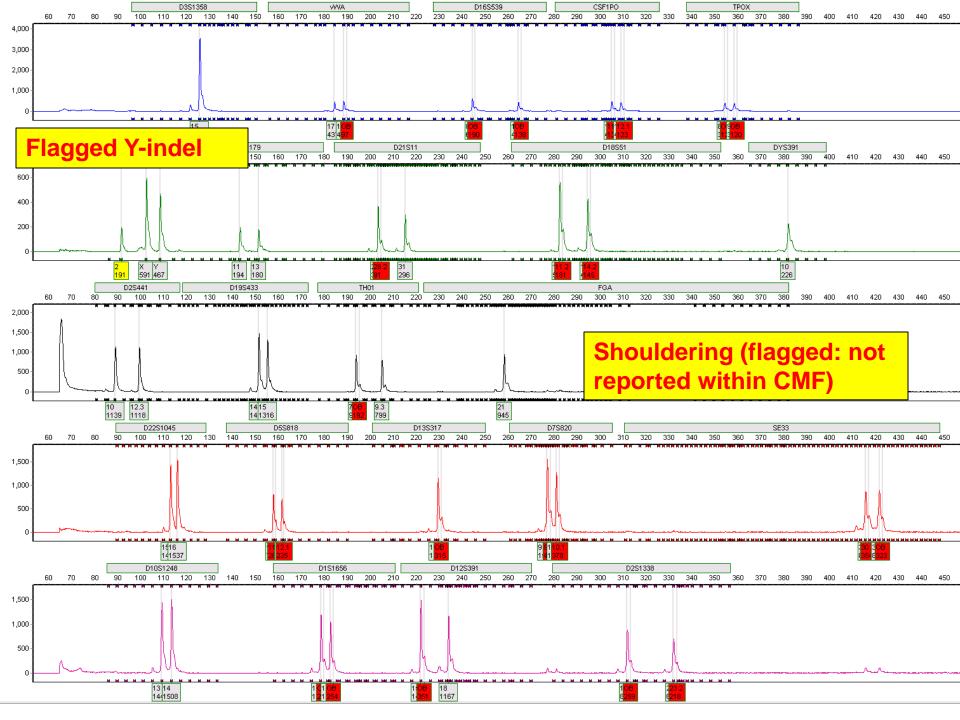


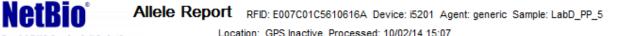
This is happening for PP16 and GFE Chemistries on the RH200

### **Report for Previous Sample**

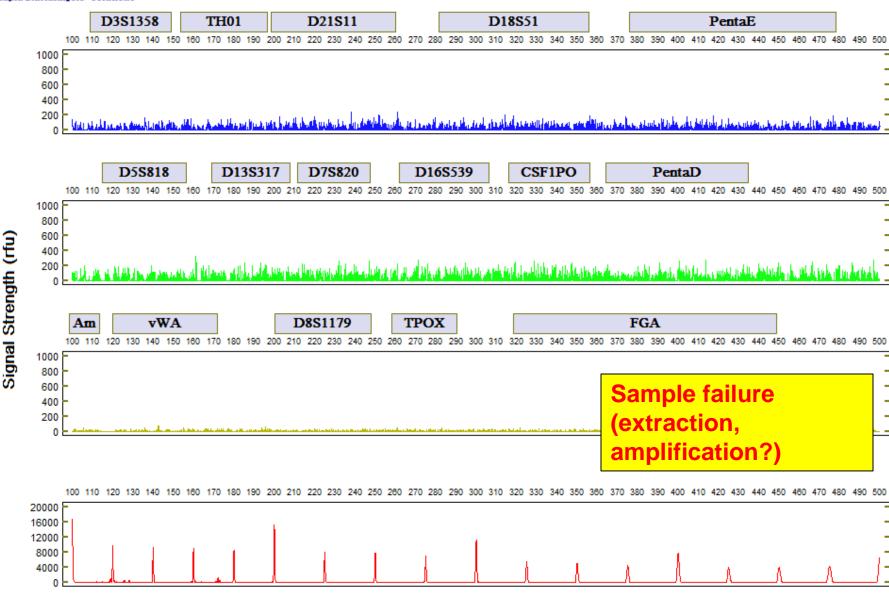
Loci	5. LabC_NN_5	-
D3S1358	15,	110
TH01	9.3,	
D21S11	30, 31,	-
D18S51	14, 20,	_
Penta E	14,	
D5S818		
D13S317	12,	
D7S820	8, 10,	
D16S539	11,	
CSF1PO	11,	) 120
Penta D	10, 13,	
AMEL	Х,	
vWA		-
D8S1179	13, 15,	-
TPOX		- 
FGA		-



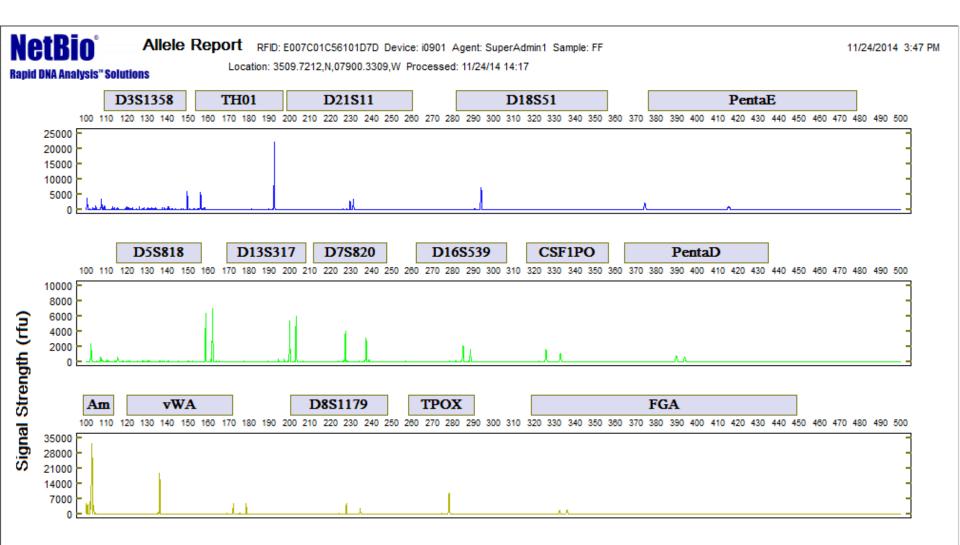




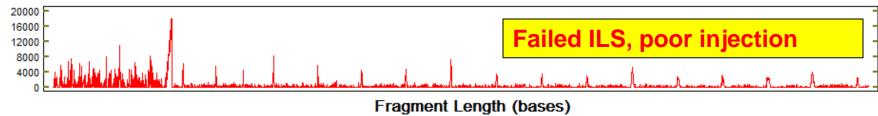


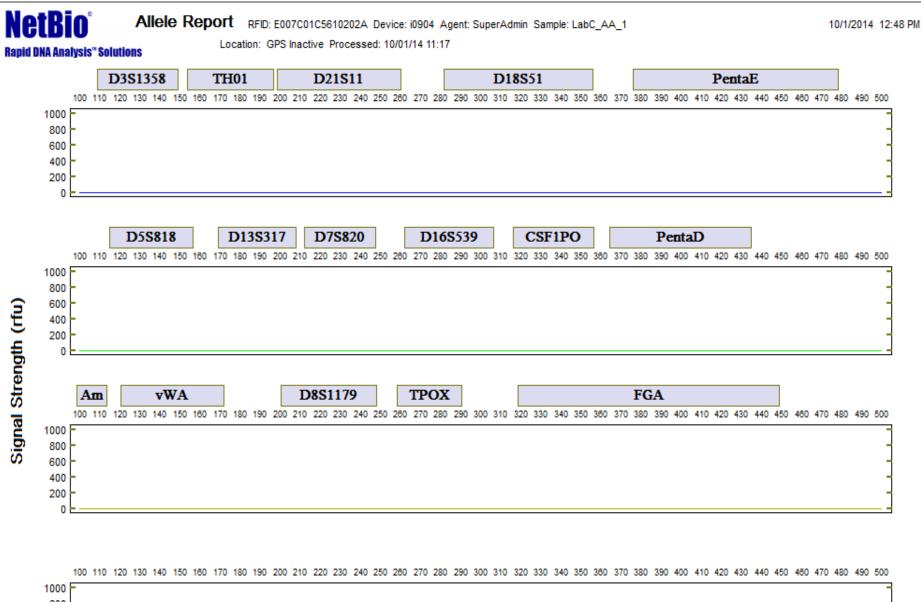


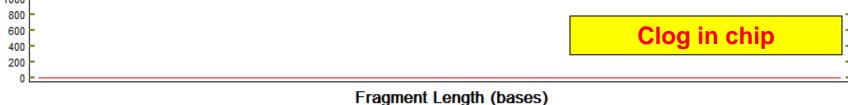
Fragment Length (bases)











### Improvements Since R-DNA MA

- Problems with IXI GFE cartridge manufacturing Summer/Fall of 2014 (during this study) Chips were redesigned in January 2015
  - Leaking buffer cartridges
  - Leaking PCR mastermix during injection of pogos
- Bad lot of polymer (exposed to extreme heat in AZ and began to break down)
- New RH200 software version (2.0)
  - Added kinship function (pair-wise comparisons)
  - Rapid DNA Process mode (complete expert mode)
    - GlobalFiler Express with GeneMarker HID 2.7

### Summary

- 2014 R-DNA Maturity Assessment exhibited a 76% success rate for the CODIS 13 Core Loci using Rapid DNA Analysis
  - Success ranged from 45% to 85% across laboratories, chemistries, and instruments
- Precision is within 0.114 bp on average for RH200 GFE
- Continuing to run R-DNA platforms with newer chemistries and upgrades
  - GFE with the RapidHIT200
  - 27plex 6-dye chemistry with ANDE

#### **Final Results**

Rapid DNA Instrument Platforms	Number of Participating Labs	Total Instruments	Samples Attempted	<b>Core CODIS</b> <b>Success</b> (Rapid DNA Analysis)	Core CODIS Success (Modified Rapid DNA Analysis)
2	7	11	280	76.1%	80.0%

Overall success for the R-DNA maturity assessment will be reported:

http://www.nist.gov/mml/bmd/genetics/dna\_biometrics.cfm

This data will be made available to the public.

### Thank you for your attention!

Thanks to David Duewer and Sanae Lembirik for assistance with data analysis

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301-975-5107

#### Funding

Performance Evaluation

**DHS** – Rapid DNA **FBI** - the Evaluation of Prototype and Kinship Forensic DNA Typing as a Biometric Tool



